

# CAPE Grand Challenge: Photonics and Electronics 2022

## Topic 1: MEMS and micromachined silicon structures

### 1. Capacitive Micromachined Ultrasonic Transducer(CMUT)

#### Project Elements

- (1) CMUT monomer and array structure design;
- (2) CMUT vibration model simulation, electromechanical coupling simulation, array element parameter design and simulation;
- (3) CMUT process design;
- (4) CMUT area array transceiver performance test;

**Requirement:** The number of array elements is not less than  $16 \times 16$ , the operating frequency is not less than 2MHz, and the relative bandwidth of -6dB is not less than 80% of the operating frequency.

### 2. Silicon-based MEMS Vibration Sensor Technology

#### Project Elements

- (1) The structure design of MEMS Vibration Sensor
- (2) The process design of MEMS Vibration Sensor
- (3) Design of Low Noise Signal Detection Circuit

**Requirement:** The frequency response range is 1-2000Hz; the acceleration measurement range is 50g, and the zero bias temperature coefficient is  $5\mu\text{g}/^\circ\text{C}$  ( $-45^\circ\text{C} \sim +85^\circ\text{C}$ )

### 3. Silicon-Based Microfluidic Heat Sink

#### Project elements

- (1) Multi-layer bifurcated structure micro-channel radiator design;
- (2) Simulation analysis of liquid flow channel characteristics in microchannels;
- (3) Research on liquid phase transition and heat dissipation characteristics in microchannels;
- (4) The influence of micro-channel structure and surface roughness on the liquid flow characteristics and heat transfer characteristics;

**Requirement:** Under the condition that the fluid flow rate is 5m/s, the temperature of the hot spot does not rise more than  $50^\circ\text{C}$ , and the maximum heat flux density of the hot spot that the radiator can cool is not less than  $150\text{W}/\text{cm}^2$ .

### 4. Getter technology for MEMS vacuum packaging

### **Project elements**

- (1) Carry out research on the preparation process of vacuum encapsulated getter materials;
- (2) Characterization of getter material, getter rate test;
- (3) Residual gas analysis in vacuum packaging chamber for packaged MEMS devices;;

**Requirement** The suction rate is not less than  $200\text{cm}^3/\text{s}/\text{cm}^2$ , the suction volume in 2h is not less than  $100\text{Pa}\cdot\text{cm}^3/\text{cm}^2$ , and the vacuum degree of vacuum packaging is better than 1Pa.

## **5. High Precision Silicon-based MEMS Oscillator Technology**

### **Project Elements**

- (1) Carry out research on the full temperature ( $-45^\circ\text{C}\sim 85^\circ\text{C}$ ) drift and frequency compensation technology of silicon-based MEMS oscillators;
- (2) Carry out the corresponding high-precision, low-noise oscillator detection circuit design

### **Requirements:**

- (1) The frequency stability of the oscillator at room temperature is better than 10ppm (1h,  $1\sigma$ );
- (2) The Q value of the silicon-based MEMS oscillator after vacuum packaging for open-loop testing is better than 200,000;
- (3) The frequency stability after oscillator compensation is controlled within  $\pm 20\text{ppm}$

## **6. Design Technology of High Quality-Factor Silicon Based Capacitive Resonant Structure**

### **Project elements**

- (1) Analysis of the damping loss mechanism of capacitive resonant structures (such as different forms of beam structures and double-ended fixed tuning fork structures) under different package vacuum degrees, and propose corresponding suppression methods to realize the design of high quality factor capacitive resonant structures;
- (2) Mechanism analysis of nonlinear vibration error source in capacitive resonant structures (beam structure, double-ended fixed tuning fork structure), and proposed structure optimization design scheme.
- (3) Full-temperature frequency stability of capacitive resonant structures (folded beams, double-ended fixed beams, etc.).

## **7. Mechanism study on the effect of impedance of the output characteristics of silicon-based MEMS capacitive sensors**

### **Project elements**

- (1) The influence mechanism and suppression method of different impedances ( $\leq 500$

M $\Omega$ , 500, M $\Omega$  ~1 G $\Omega$ ,  $\geq$ 1 G $\Omega$ ) on the output characteristics of silicon-based capacitive sensors.